

Notice of References Cited	Application/Control No. 10/509,007	Applicant(s)/Patent Under Reexamination ASPAR ET AL.	
	Examiner M. Wilczewski	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,693,342	02-2004	Larson et al.	257/522
*	B	US-6,429,094	08-2002	Maleville et al.	438/455
*	C	US-6,933,210	08-2005	Inoue, Satoshi	438/455
*	D	US-6,809,009	10-2004	Aspar et al.	438/459
*	E	US-6,989,314	01-2006	Rayssac et al.	438/406
*	F	US-6,974,759	12-2005	Moriceau et al.	438/459
*	G	US-2006/0079071	04-2006	Moriceau et al.	438/459
*	H	US-2006/0076559	04-2006	Faure et al.	257/049
*	I	US-2006/0063353	03-2006	Akatsu, Takeshi	438/455
*	J	US-2006/0035440	02-2006	Ghyselen et al.	438/458
*	K	US-2006/0014363	01-2006	Daval et al.	438/455
*	L	US-2005/0245049	11-2005	Akatsu et al.	438/458
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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